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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/766,334	01/28/2004	Michael Ching	RAMB-01050US0	3273
7590	10/03/2006			EXAMINER
kirk J. DeNiro, Esq. Vierra ,Magen, Marcus, Harmon & DeNiro LLP 685 Market Street Suite 540 San Francisco, CA 94105			NGUYEN, BRIAN D	
			ART UNIT	PAPER NUMBER
			2616	
DATE MAILED: 10/03/2006				

Please find below and/or attached an Office communication concerning this application or proceeding.

<b>Examiner-Initiated Interview Summary</b>	<b>Application No.</b>	<b>Applicant(s)</b>
	10/766,334	CHING ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Brian D. Nguyen	2616

**All Participants:****Status of Application:** \_\_\_\_\_(1) Brian D. Nguyen.

(3) \_\_\_\_\_.

(2) Kirk DeNiro.

(4) \_\_\_\_\_.

**Date of Interview:** 27 September 2006**Time:** \_\_\_\_\_**Type of Interview:**

- Telephonic  
 Video Conference  
 Personal (Copy given to:  Applicant     Applicant's representative)

**Exhibit Shown or Demonstrated:**  Yes     No

If Yes, provide a brief description: \_\_\_\_\_

**Part I.**

Rejection(s) discussed:

Claims discussed:

7 and 9

Prior art documents discussed:

**Part II.****SUBSTANCE OF INTERVIEW DESCRIBING THE GENERAL NATURE OF WHAT WAS DISCUSSED:***Replace previous examiner's amendment with a supplemental examiner's amendment to correct the typographical error.***Part III.**

- It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview directly resulted in the allowance of the application. The examiner will provide a written summary of the substance of the interview in the Notice of Allowability.  
 It is not necessary for applicant to provide a separate record of the substance of the interview, since the interview did not result in resolution of all issues. A brief summary by the examiner appears in Part II above.

(Examiner/SPE Signature)

(Applicant/Applicant's Representative Signature – if appropriate)

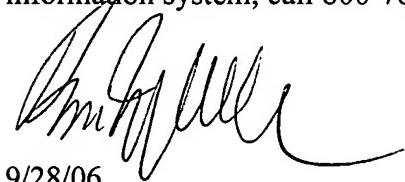
#### **EXAMINER'S AMENDMENT**

1. This examiner's amendment will replace the previous examiner's amendment.
2. An examiner's amendment to the record appears below. Should the changes and/or additions be unacceptable to applicant, an amendment may be filed as provided by 37 CFR 1.312. To ensure consideration of such an amendment, it MUST be submitted no later than the payment of the issue fee.
3. Authorization for this examiner's amendment was given in a telephone interview with Kirk DeNiro on 9/27/06.
4. The application has been amended as follows:

**Claims 7 and 9**, replace "the data" with --a data packet--.
5. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Brian D. Nguyen whose telephone number is (571) 272-3084. The examiner can normally be reached on 7:30-6:00 Monday-Thursday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Wellington Chin can be reached on (571) 272-3134. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.



9/28/06

BRIAN NGUYEN  
PRIMARY EXAMINER